

- Load Clocks and Unload Clocks Can Be Asynchronous or Coincident
- 2048 Words by 9 Bits
- Low-Power Advanced CMOS Technology
- Fast Access Times of 15 ns With a 50-pF Load
- Programmable Almost-Full/Almost-Empty Flag
- Expansion Logic for Depth Cascading
- Empty, Full, and Half-Full Flags
- Fall-Through Time of 20 ns Typical
- Data Rates up to 50 MHz
- 3-State Outputs
- Package Options Include 44-Pin Plastic Leaded Chip Carrier (FN), 64-Pin Thin Quad Flat (PM), and Reduced-Height 64-Pin Quad Flat (PAG) Packages

### description

A FIFO memory is a storage device that allows data to be written into and read from its array at independent data rates. The SN74ACT7808 is a 2048-word by 9-bit FIFO designed for high speed and fast access times. It processes data at rates up to 50 MHz and access times of 15 ns in a bit-parallel format.

Data is written into memory on a low-to-high transition at the load-clock (LDCK) input and is read out on a low-to-high transition at the unload-clock (UNCK) input. The memory is full when the number of words clocked in exceeds the number of words clocked out by 2048. When the memory is full, LDCK signals have no effect on the data residing in memory. When the memory is empty, UNCK signals have no effect.

Status of the FIFO memory is monitored by the full ( $\overline{\text{FULL}}$ ), empty ( $\overline{\text{EMPTY}}$ ), half-full (HF), and almost-full/almost-empty (AF/AE) flags. The  $\overline{\text{FULL}}$  output is low when the memory is full and high when the memory is not full. The  $\overline{\text{EMPTY}}$  output is low when the memory is empty and high when it is not empty. The HF output is high when the FIFO contains 1024 or more words and is low when it contains 1023 or fewer words. The AF/AE status flag is a programmable flag. The first one or two low-to-high transitions of LDCK after reset can be used to program the almost-empty offset value (X) and the almost-full offset value (Y) if program enable ( $\overline{\text{PEN}}$ ) is low. The AF/AE flag is high when the FIFO contains X or fewer words or  $(2048 - Y)$  or more words. The AF/AE flag is low when the FIFO contains between  $(X + 1)$  and  $(2047 - Y)$  words.

A low level on the reset ( $\overline{\text{RESET}}$ ) input resets the internal stack pointers and sets  $\overline{\text{FULL}}$  high, AF/AE high, HF low, and  $\overline{\text{EMPTY}}$  low. The Q outputs are not reset to any specific logic level.

The first word loaded into empty memory causes  $\overline{\text{EMPTY}}$  to go high and the data to appear on the Q outputs. It is important to note that the first word does not have to be unloaded. Data outputs are noninverting with respect to the data inputs and are in the high-impedance state when the output-enable (OE) input is low. OE does not affect the output flags.

Cascading is easily accomplished in the word-width and word-depth directions. When not using the FIFO in depth expansion, cascade enable ( $\overline{\text{CASCEN}}$ ) must be tied high.

The FIFO must be reset upon power up.

The SN74ACT7808 is characterized for operation from 0°C to 70°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

 **TEXAS  
INSTRUMENTS**

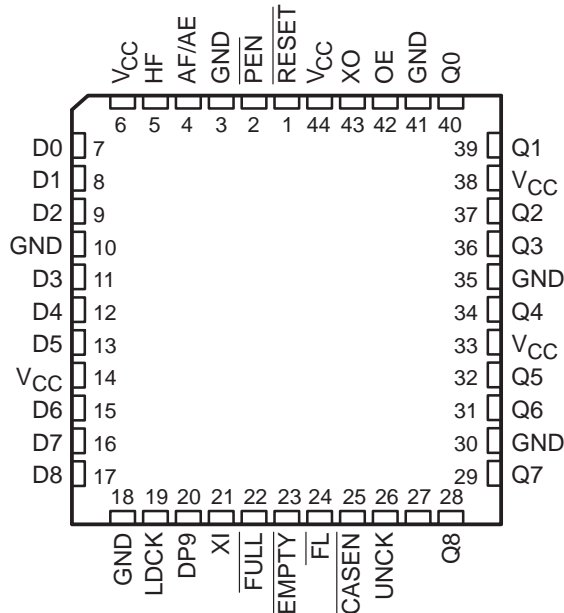
POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

Copyright © 1998, Texas Instruments Incorporated

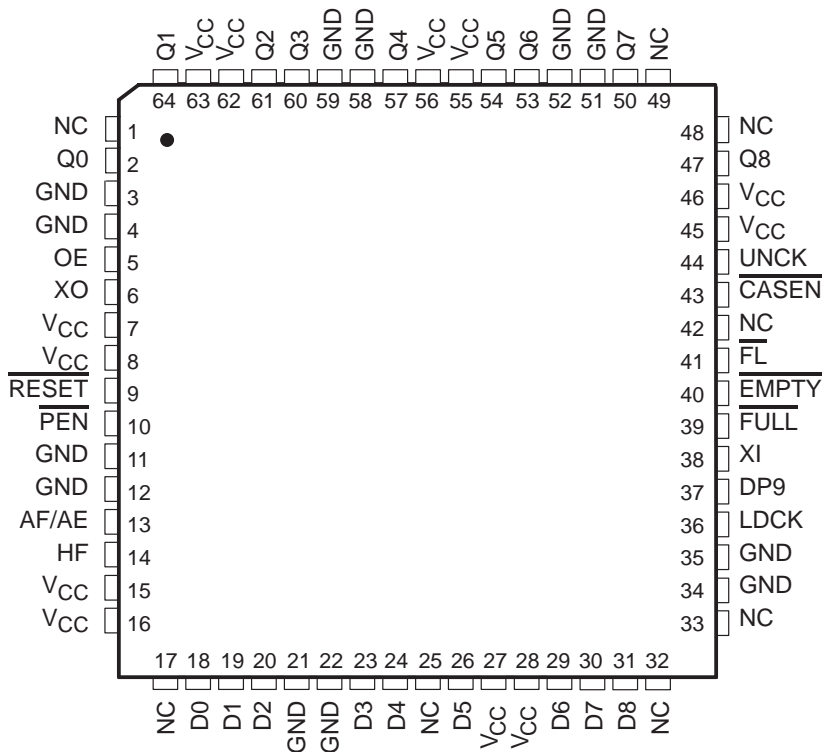
## 2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

**(TOP VIEW)**



**(TOP VIEW)**



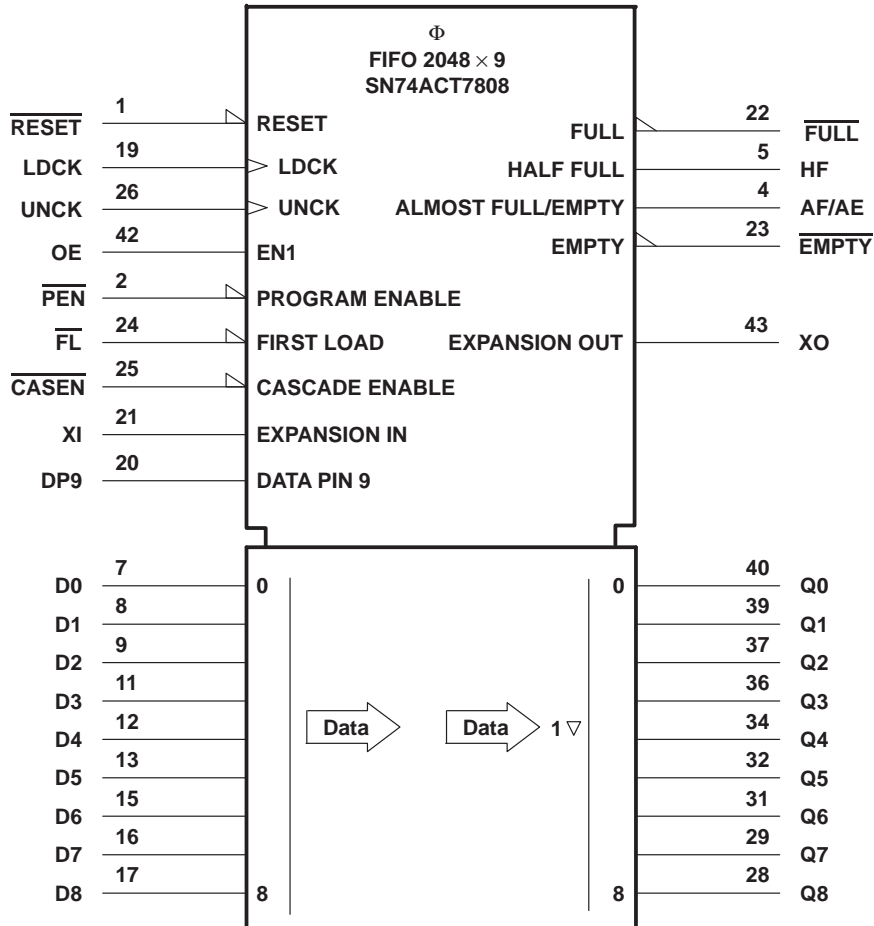
NC – No internal connection

# SN74ACT7808

## 2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

logic symbol†

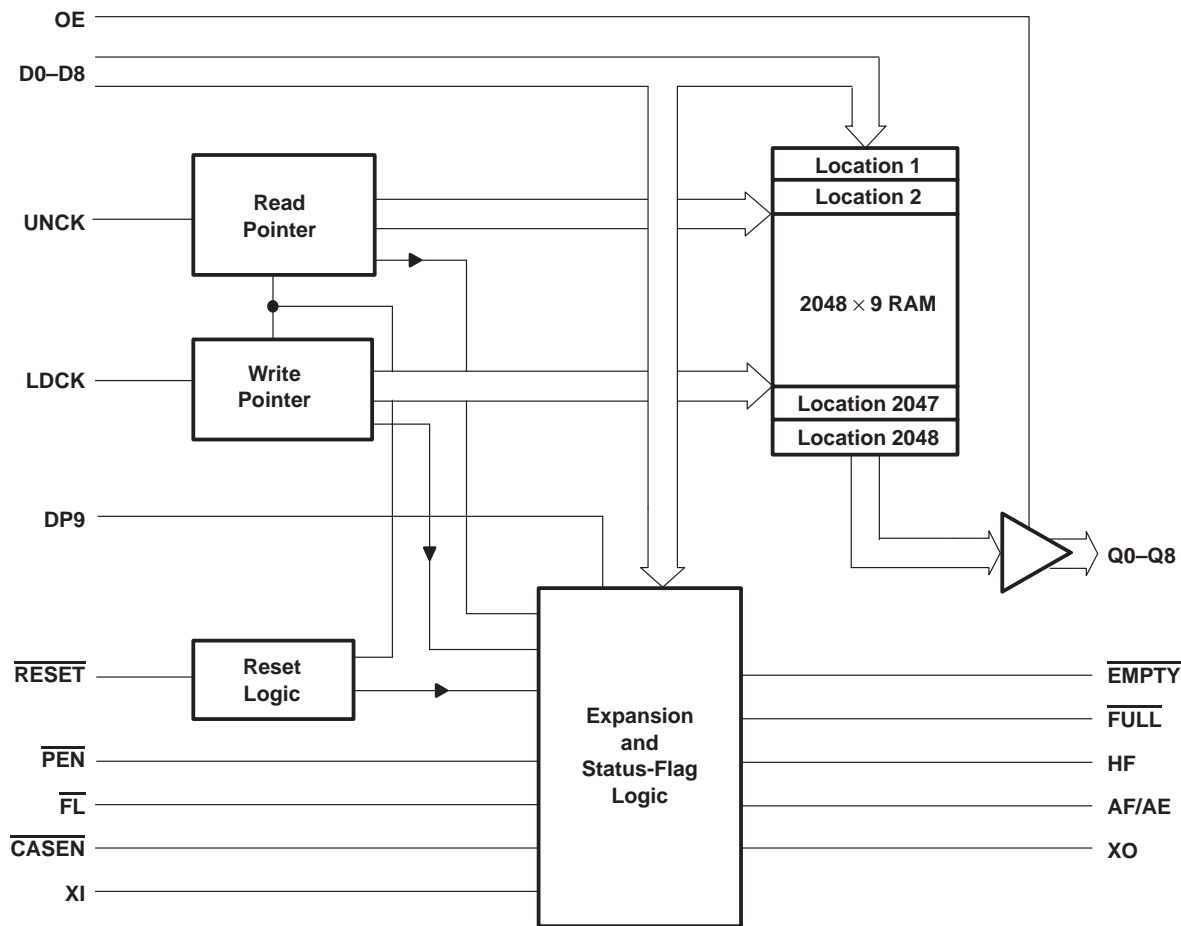


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.  
Pin numbers shown are for the FN package.

SN74ACT7808  
2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

functional block diagram



# SN74ACT7808

## 2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

### Terminal Functions

TERMINAL NAME	I/O	DESCRIPTION
AF/AE	O	Almost-full/almost-empty flag. Depth-offset values can be programmed for AF/AE or the default value of 256 can be used for both the almost-empty offset (X) and the almost-full offset (Y). AF/AE is high when memory contains X or fewer words or (2048 – Y) or more words. AF/AE is high after reset.
$\overline{\text{CASEN}}^\dagger$	I	Cascade enable. When multiple SN74ACT7808 devices are depth cascaded, every device must have $\overline{\text{CASEN}}$ tied low. $\overline{\text{CASEN}}$ must be tied high when a device is not used in depth expansion.
D0–D8	I	Nine-bit data input port
DP9	I	DP9 is used as the most significant bit when programming the AF/AE offset values.
$\overline{\text{EMPTY}}$	O	Empty flag. $\overline{\text{EMPTY}}$ is low when the FIFO memory is empty. A FIFO reset also causes $\overline{\text{EMPTY}}$ to go low.
$\overline{\text{FL}}^\dagger$	I	First load. When multiple SN74ACT7808 devices are depth cascaded, the first device in the chain must have its $\overline{\text{FL}}$ input tied low and all other devices must have their $\overline{\text{FL}}$ inputs tied high.
$\overline{\text{FULL}}$	O	Full flag. $\overline{\text{FULL}}$ is low when the FIFO is full. A FIFO reset causes $\overline{\text{FULL}}$ to go high.
HF	O	Half-full flag. HF is high when the FIFO memory contains 1024 or more words. HF is low after reset.
LDCK	I	Load clock. Data is written to the FIFO on the rising edge of LDCK when $\overline{\text{FULL}}$ is high.
OE	I	Output enable. When OE is low, D0–D8 are in the high-impedance state.
$\overline{\text{PEN}}$	I	Program enable. After reset and before the first word is written to the FIFO, the binary value on D0–D8 and DP9 is latched as an AF/AE offset value when $\overline{\text{PEN}}$ is low and LDCK is high.
Q0–Q8	O	Nine-bit data output port
$\overline{\text{RESET}}$	I	Reset. A low level on $\overline{\text{RESET}}$ resets the FIFO and drives $\overline{\text{FULL}}$ and AF/AE high and HF and $\overline{\text{EMPTY}}$ low.
UNCK	I	Unload clock. Data is read from the FIFO on the rising edge of UNCK when $\overline{\text{EMPTY}}$ is high.
$\text{XI}^\dagger$	I	Expansion input (XI) and expansion output (XO). When multiple SN74ACT7808 devices are depth cascaded, the XO of one device must be connected to the XI of the next device in the chain. The XO of the last device in the chain is connected to the XI of the first device in the chain.
$\text{XO}^\dagger$	O	

<sup>†</sup> See Figures 6 and 7 for application information on FIFO word-width and word-depth expansions, respectively.



# SN74ACT7808

## 2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

### offset values for AF/AE

The AF/AE flag has two programmable limits: the almost-empty offset value (X) and the almost-full offset value (Y). They can be programmed after the FIFO is reset and before the first word is written to memory. If the offsets are not programmed, the default values of  $X = Y = 256$  are used. The AF/AE flag is high when the FIFO contains X or fewer words or  $(2048 - Y)$  or more words.

To program the offset values, program enable ( $\overline{PEN}$ ) can be brought low after reset only when LDCK is low. On the following low-to-high transition of LDCK, the binary value on D0–D8 and DP9 is stored as the almost-empty offset value (X) and the almost-full offset value (Y). Holding  $\overline{PEN}$  low for another low-to-high transition of LDCK reprograms Y to the binary value on D0–D8 and DP9 at the time of the second LDCK low-to-high transition. Writes to the FIFO memory are disabled while the offsets are programmed. A maximum value of 1023 can be programmed for either X or Y (see Figure 1). To use the default values of  $X = Y = 256$ ,  $\overline{PEN}$  must be held high.

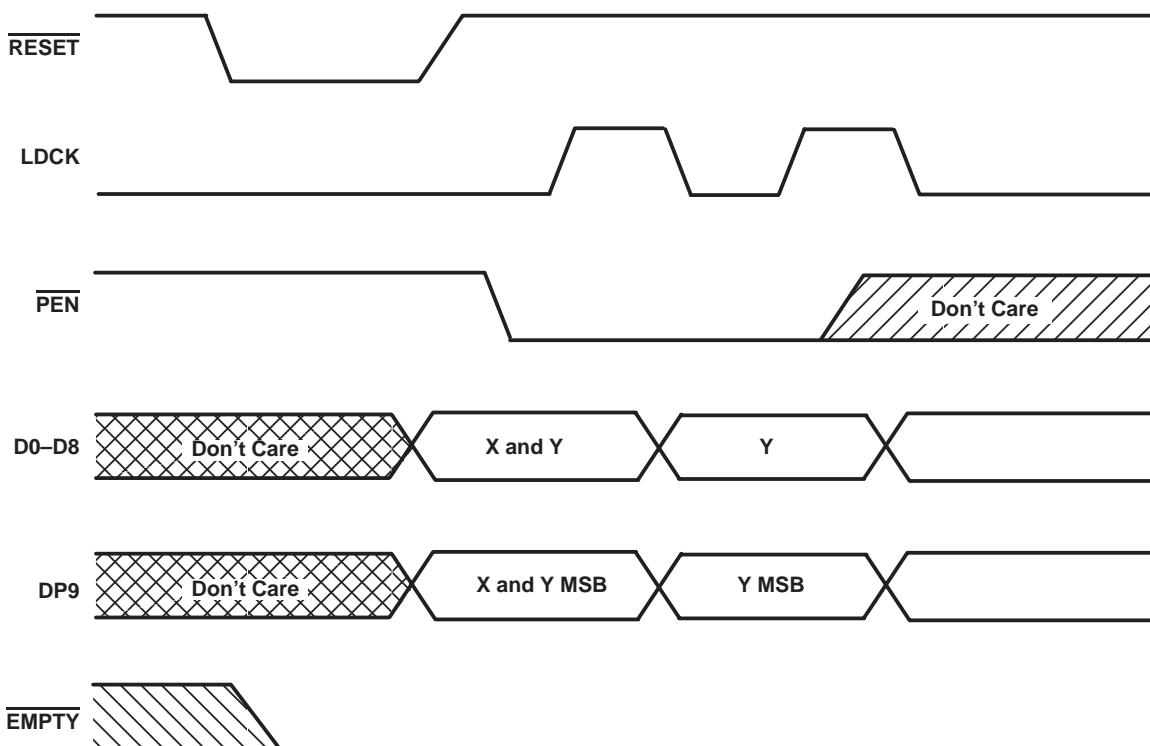


Figure 1. Programming X and Y Separately

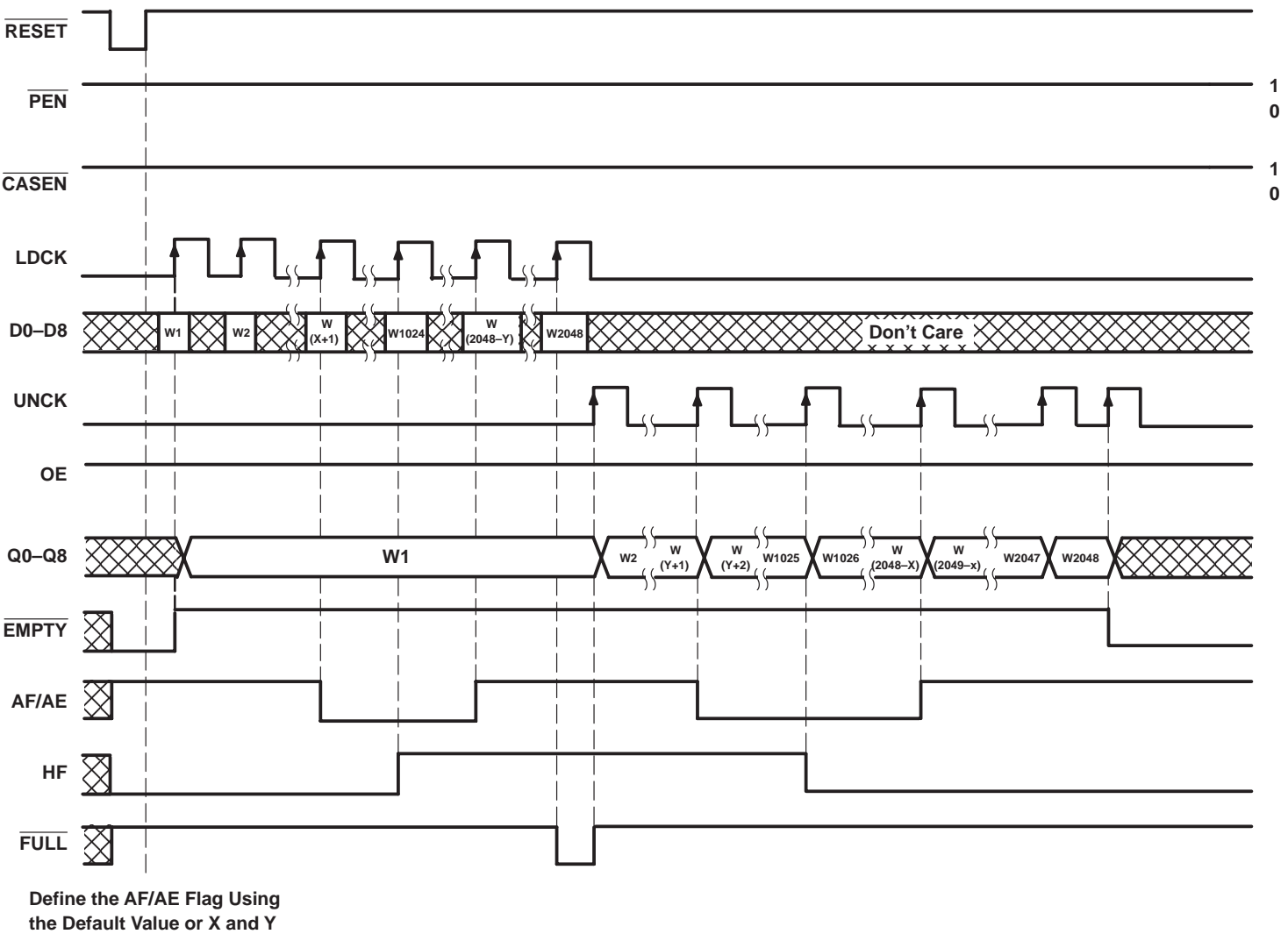


Figure 2. Read

# SN74ACT7808

## 2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, $V_{CC}$	–0.5 V to 7 V
Input voltage range, $V_I$	–0.5 V to 7 V
Voltage range applied to a disabled 3-state output	–0.5 V to 5.5 V
Package thermal impedance, $\theta_{JA}$ (see Note 1): FN package	46°C/W
PAG package	58°C/W
PM package	67°C/W
Storage temperature range, $T_{stg}$	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

### recommended operating conditions

			'ACT7808-20		'ACT7808-25		'ACT7808-30		'ACT7808-40		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
$V_{CC}$	Supply voltage		4.5	5.5	4.5	5.5	4.5	5.5	4.5	5.5	V
$V_{IH}$	High-level input voltage	XI	3.85		3.85		3.85		3.85		V
		Other inputs	2		2		2		2		
$V_{IL}$	Low-level input voltage			0.8		0.8		0.8		0.8	V
$I_{OH}$	High-level output current			–8		–8		–8		–8	mA
$I_{OL}$	Low-level output current	Q outputs		16		16		16		16	mA
		Flags		8		8		8		8	
$T_A$	Operating free-air temperature		0	70	0	70	0	70	0	70	°C

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP <sup>‡</sup>	MAX	UNIT
$V_{OH}$		$V_{CC} = 4.5\text{ V}$ ,	$I_{OH} = -8\text{ mA}$	2.4			V
$V_{OL}$	Flags	$V_{CC} = 4.5\text{ V}$ ,	$I_{OL} = 8\text{ mA}$			0.5	V
	Q outputs	$V_{CC} = 4.5\text{ V}$ ,	$I_{OL} = 16\text{ mA}$			0.5	
$I_I$		$V_{CC} = 5.5\text{ V}$ ,	$V_I = V_{CC}$ or 0			±5	μA
$I_{OZ}$		$V_{CC} = 5.5\text{ V}$ ,	$V_O = V_{CC}$ or 0			±5	μA
$I_{CC}$		$V_{CC} = 5.5\text{ V}$ ,	$V_I = V_{CC} - 0.2\text{ V}$ or 0			400	μA
$\Delta I_{CC}^{\S}$		$V_{CC} = 5.5\text{ V}$ ,	One input at 3.4 V, Other inputs at $V_{CC}$ or GND			1	mA
$C_i$		$V_I = 0$ ,	$f = 1\text{ MHz}$		4		pF
$C_o$		$V_O = 0$ ,	$f = 1\text{ MHz}$		8		pF

<sup>‡</sup> All typical values are at  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

<sup>§</sup> This is the increase in supply current for each input, excluding XI, that is at one of the specified TTL voltage levels rather 0 V or  $V_{CC}$ .



POST OFFICE BOX 655303 • DALLAS, TEXAS 75265



# SN74ACT7808

## 2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

**timing requirements over recommended operating conditions (unless otherwise noted) (see Figures 1 through 3)**

			'ACT7808-20		'ACT7808-25		'ACT7808-30		'ACT7808-40		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency		50		40		33.3		25		MHz
t <sub>w</sub>	Pulse duration	LDCK high or low	8		9		11		13		ns
		UNCK high or low	8		9		11		13		
		PEN low	9		9		11		13		
		RESET low	10		13		16		19		
t <sub>su</sub>	Setup time	D0–D8, DP9 before LDCK↑	5		5		5		5		ns
		LDCK inactive before RESET high	5		5		5		5		
		PEN before LDCK↑	5		5		5		5		
t <sub>h</sub>	Hold time	D0–D8, DP9 after LDCK↑	0		0		0		0		ns
		LDCK inactive after RESET high	5		5		5		5		
		PEN low after LDCK↑	4		4		4		4		
		PEN high after LDCK low	0		0		0		0		

**switching characteristics over recommended ranges of supply voltage and operating free-air temperature, C<sub>L</sub> = 50 pF (unless otherwise noted) (see Figure 3)**

PARAMETER	FROM (INPUT)	TO (OUTPUT)	'ACT7808-20			'ACT7808-25		'ACT7808-30		'ACT7808-40		UNIT
			MIN	TYP†	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>	LDCK or UNCK		50			40		33.3		25		MHz
t <sub>pd</sub>	LDCK↑	Any Q	5			5		5		5		ns
	UNCK↑		4.5			4.5		4.5		4.5		
t <sub>pd</sub> ‡	UNCK↑	Any Q	10									ns
t <sub>PLH</sub>	LDCK↑	EMPTY	4			4		4		4		ns
t <sub>PHL</sub>	UNCK↑	EMPTY	2			2		2		2		ns
	RESET <sub>low</sub>		2			2		2		2		
	LDCK↑	FULL	4			4		4		4		
t <sub>PLH</sub>	UNCK↑	FULL	4			4		4		4		ns
	RESET <sub>low</sub>		2			2		2		2		
t <sub>pd</sub>	LDCK↑	AF/AE	2			2		2		2		ns
	UNCK↑		2			2		2		2		
t <sub>PLH</sub>	RESET <sub>low</sub>	AF/AE	0			0		0		0		ns
	LDCK↑	HF	2			2		2		2		
t <sub>PHL</sub>	UNCK↑	HF	2			2		2		2		ns
	RESET <sub>low</sub>		2			2		2		2		
t <sub>PLH</sub>	UNCK↑	XO	2			2		2		2		ns
t <sub>PHL</sub>	LDCK↑	XO	2			2		2		2		ns
t <sub>en</sub>	OE	Any Q	1			1		1		1		ns
t <sub>dis</sub>	OE	Any Q	1			1		1		1		ns
t <sub>en</sub>	XI high	Any Q	3			3		3		3		ns
t <sub>dis</sub>	XO high	Any Q	4			4		4		4		ns

† All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

‡ This parameter is measured with C<sub>L</sub> = 30 pF (see Figure 4).



POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

SN74ACT7808

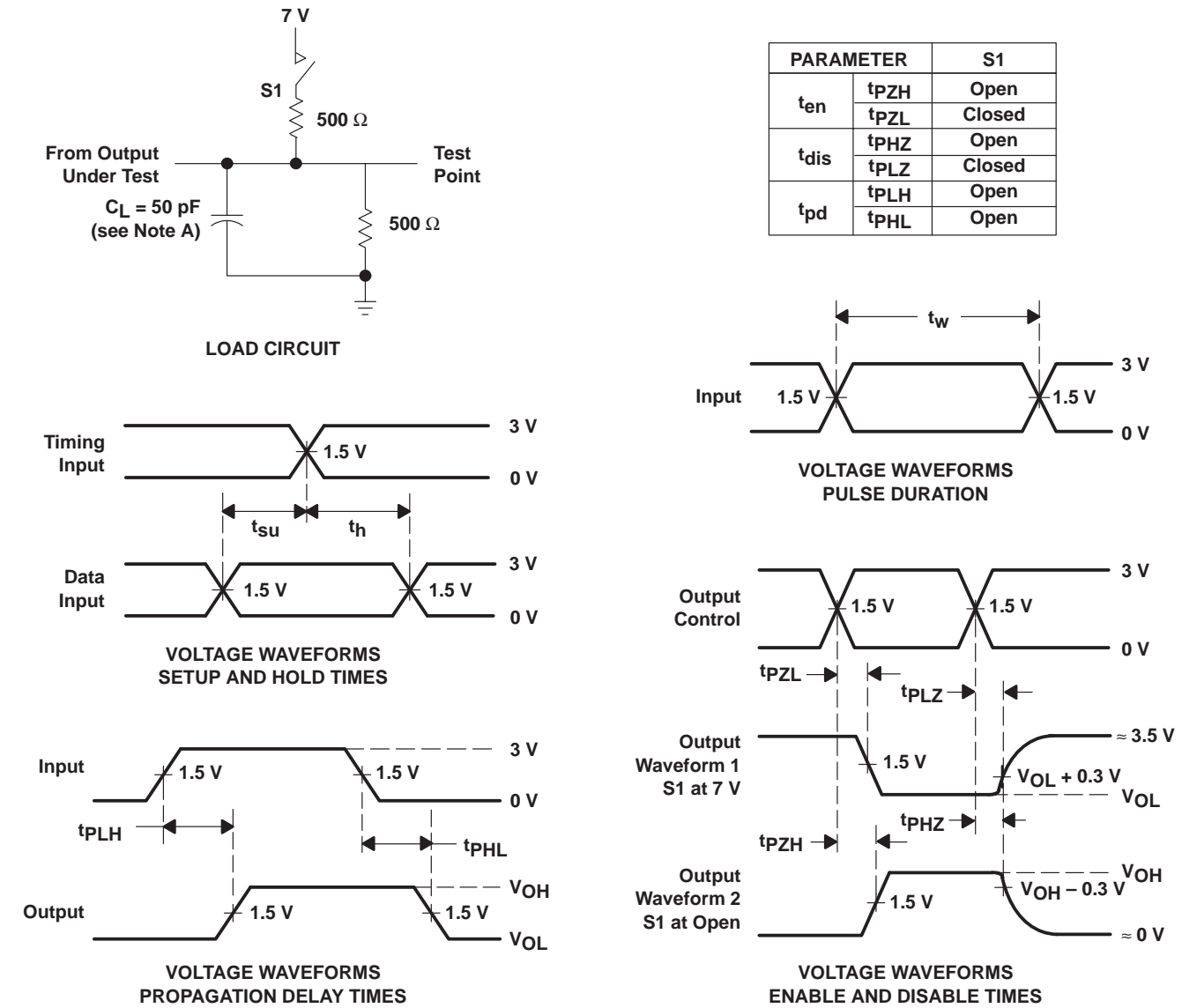
2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

operating characteristics,  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^{\circ}\text{C}$

PARAMETER			TEST CONDITIONS	TYP	UNIT
$C_{pd}$	Power dissipation capacitance per FIFO channel	Outputs enabled	$C_L = 50\text{ pF}$ , $f = 5\text{ MHz}$	91	pF

PARAMETER MEASUREMENT INFORMATION



NOTE A:  $C_L$  includes probe and jig capacitance.

Figure 3. Load Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS

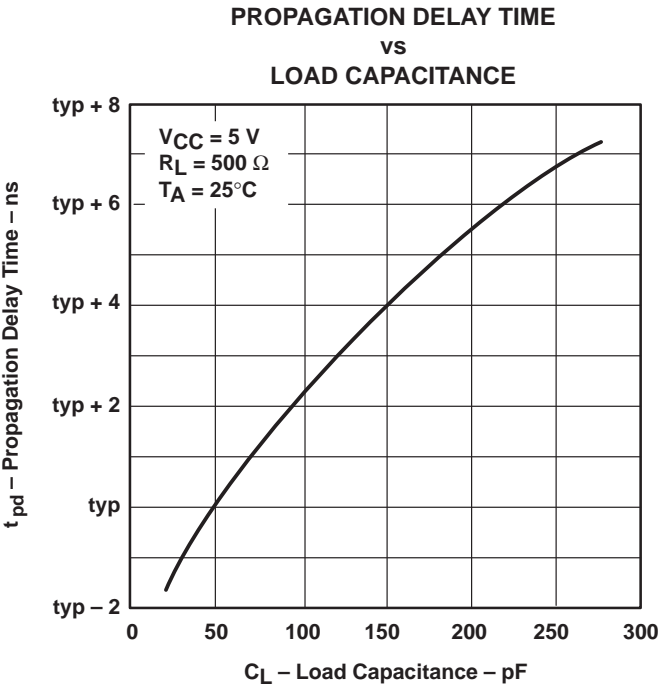


Figure 4

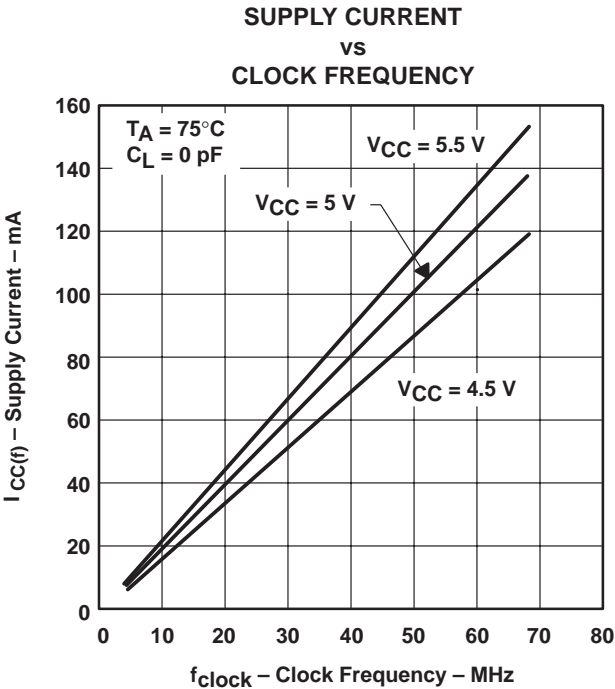
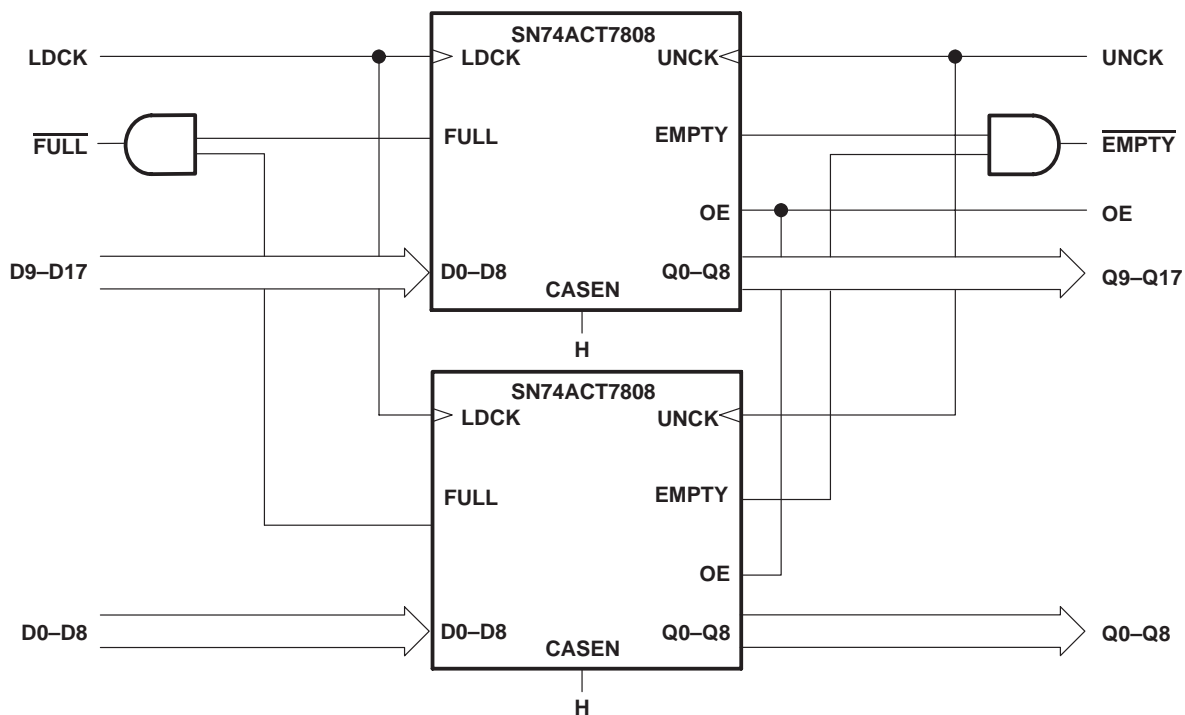


Figure 5

## 2048 × 9 STROBED FIRST-IN, FIRST-OUT MEMORY

SCAS205D – FEBRUARY 1991 – REVISED APRIL 1998

## APPLICATION INFORMATION

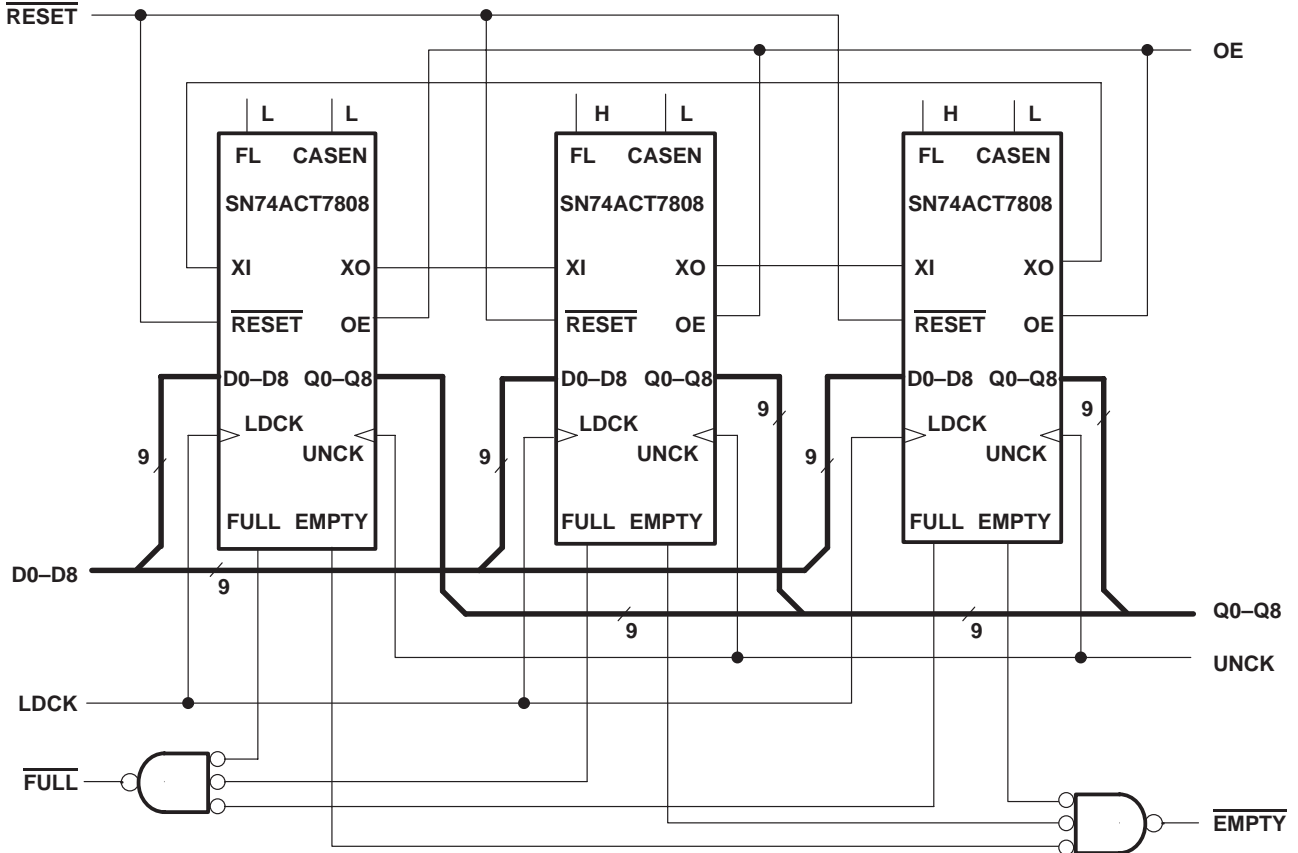


**Figure 6. Word-Width Expansion:  $2048 \times 18$  Bits**

## APPLICATION INFORMATION

### depth cascading (see Figure 7)

The SN74ACT7808 provides expansion logic necessary for cascading an unlimited number of the FIFOs in depth.  $\overline{\text{CASEN}}$  must be low on all FIFOs used in depth expansion.  $\overline{\text{FL}}$  must be tied low on the first FIFO in the chain; all others must have  $\overline{\text{FL}}$  tied high. The expansion-out (XO) output of a FIFO must be tied to the expansion-in (XI) input of the next FIFO in the chain. The XO output of the last FIFO is tied to the XI input of the first FIFO to complete the loop. Data buses are common to each FIFO in the chain. A composite EMPTY and FULL signal must be generated to indicate boundary conditions.



**Figure 7. Depth Cascading to Form a 6K × 9 FIFO**

## **IMPORTANT NOTICE**

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.